

Device Modeling Report

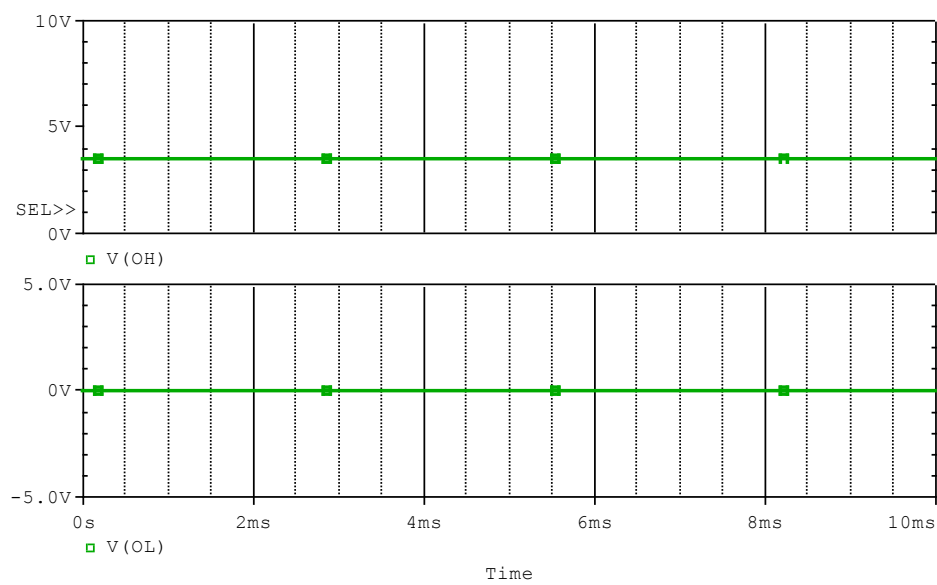
COMPONENTS: OPERATIONAL AMPLIFIER
PART NUMBER: LA6324N
MANUFACTURER: SANYO Semiconductors



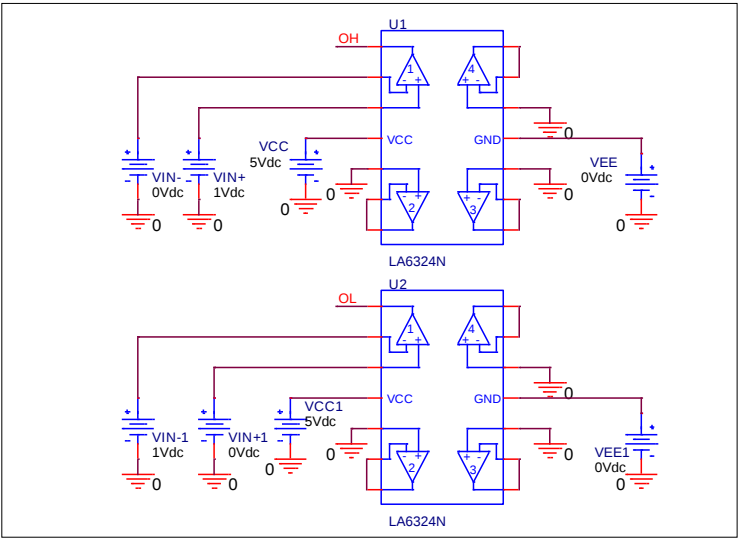
Bee Technologies Inc.

Output Voltage Swing

Simulation result



Evaluation circuit

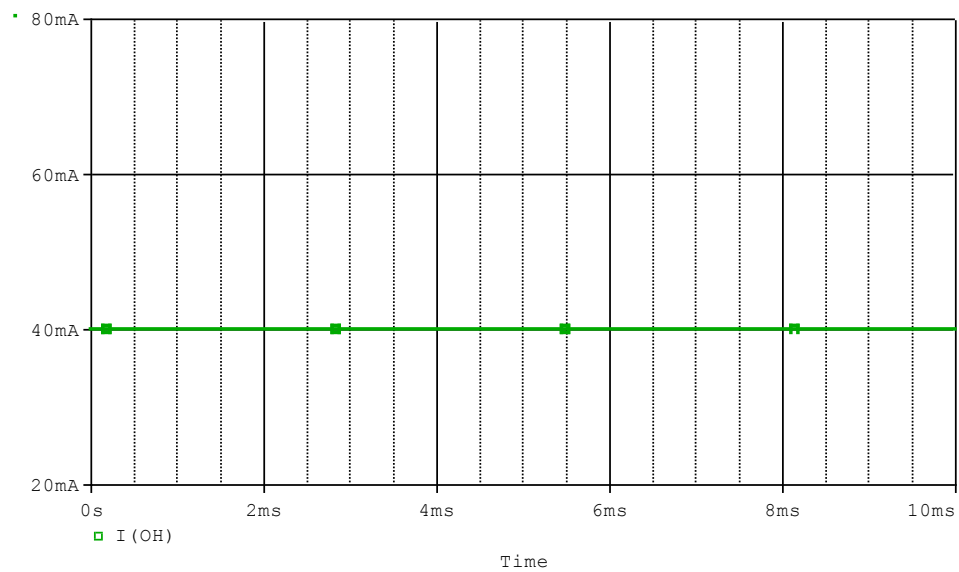


Comparison table

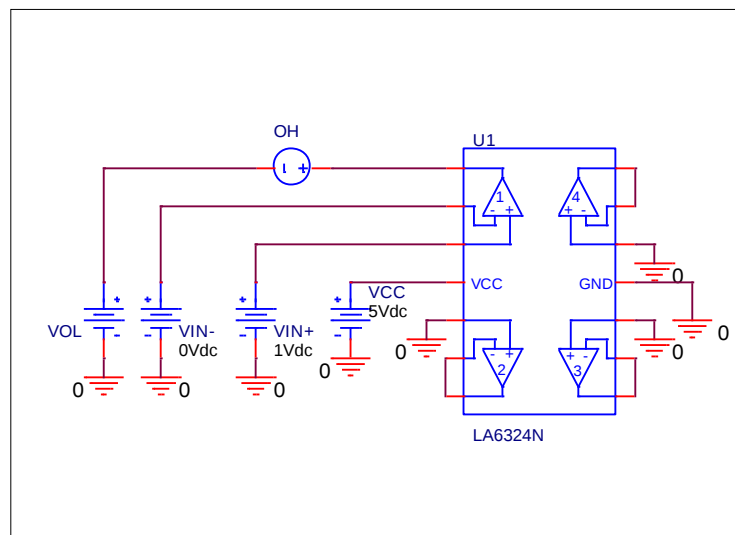
Parameter	Measurement	Simulation	%Error
VOH (V)	3.500	3.500	0.01
VOL (V)	0.000	0.000	0.00

Short Circuit Current

Simulation result



Evaluation circuit

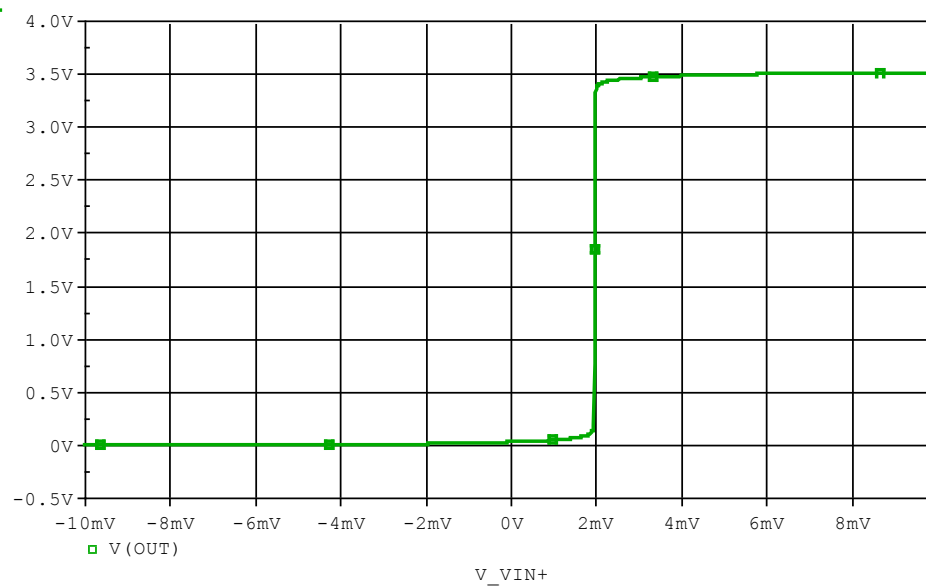


Comparison table

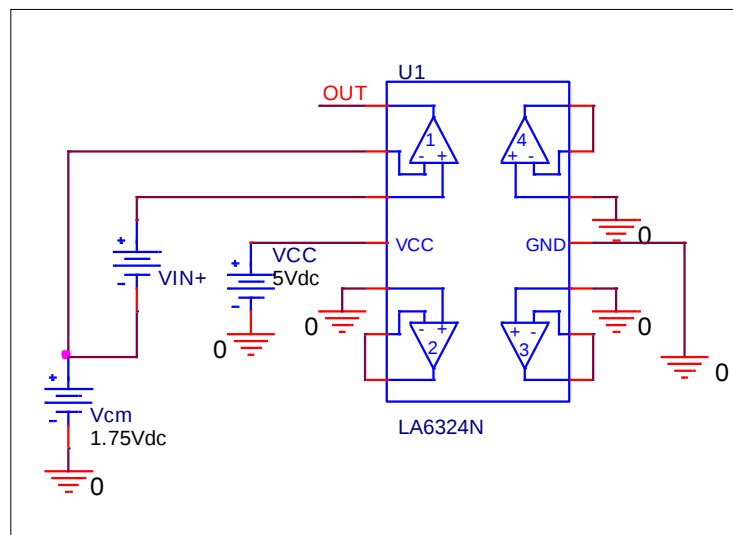
Parameter	Measurement	Simulation	%Error
IOS (mA)	40.000	40.095	0.24

Input Offset Voltage

Simulation result



Evaluation circuit

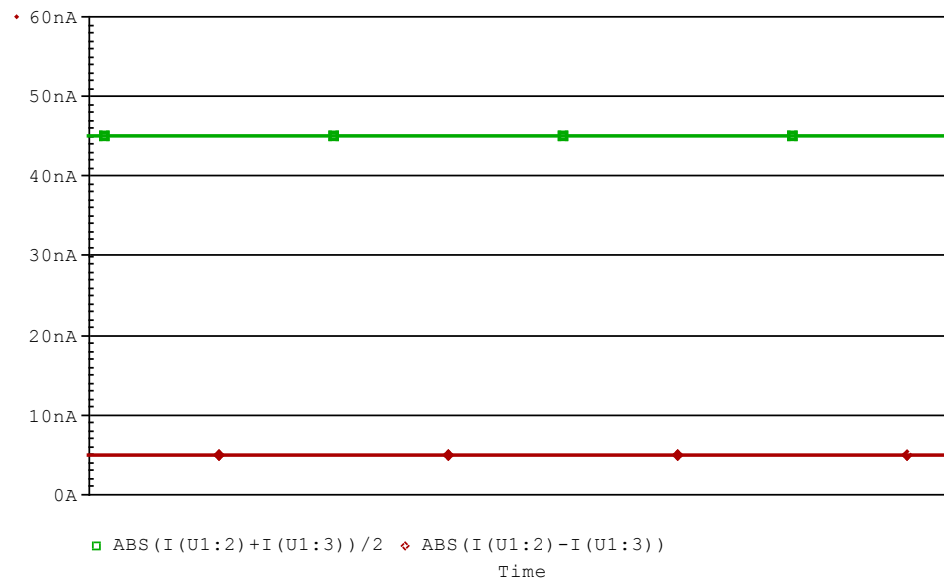


Comparison table

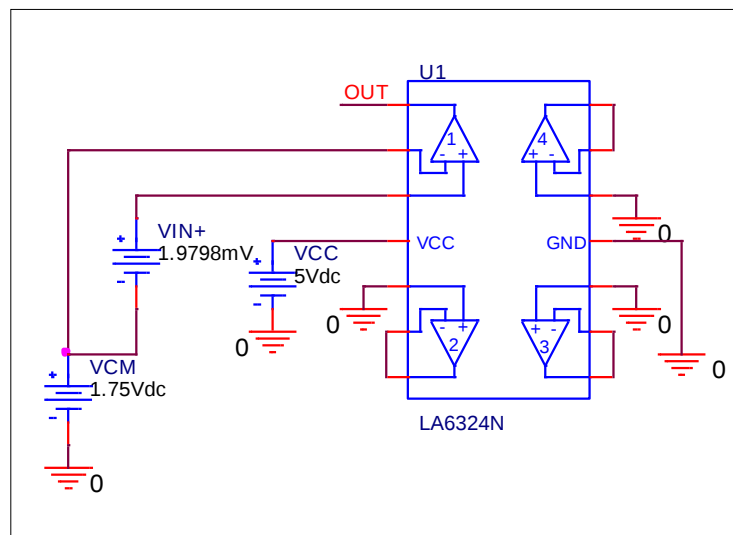
Parameter	Measurement	Simulation	%Error
Vio (mV)	2.000	1.980	-1.01

Input Current Ib, Ibos

Simulation result



Evaluation circuit

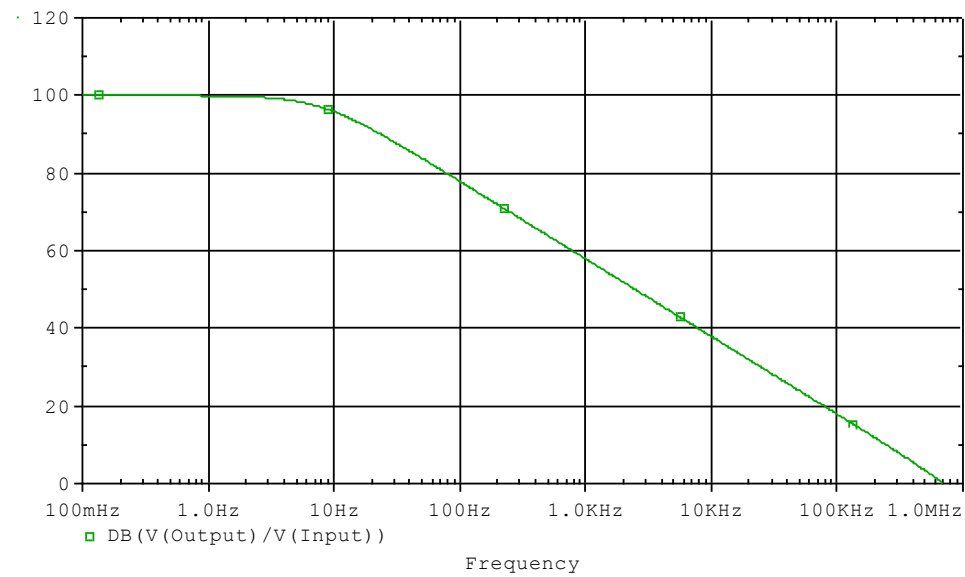


Comparison table

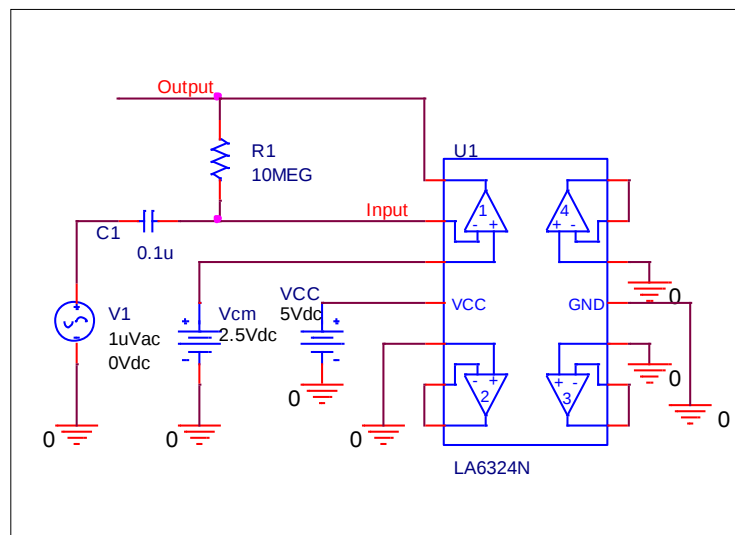
Parameter	Measurement	Simulation	%Error
I_{IO} (nA)	5.000	4.972	-0.56
I_b (nA)	45.000	45.036	0.08

Open loop voltage gain

Simulation result



Evaluation circuit

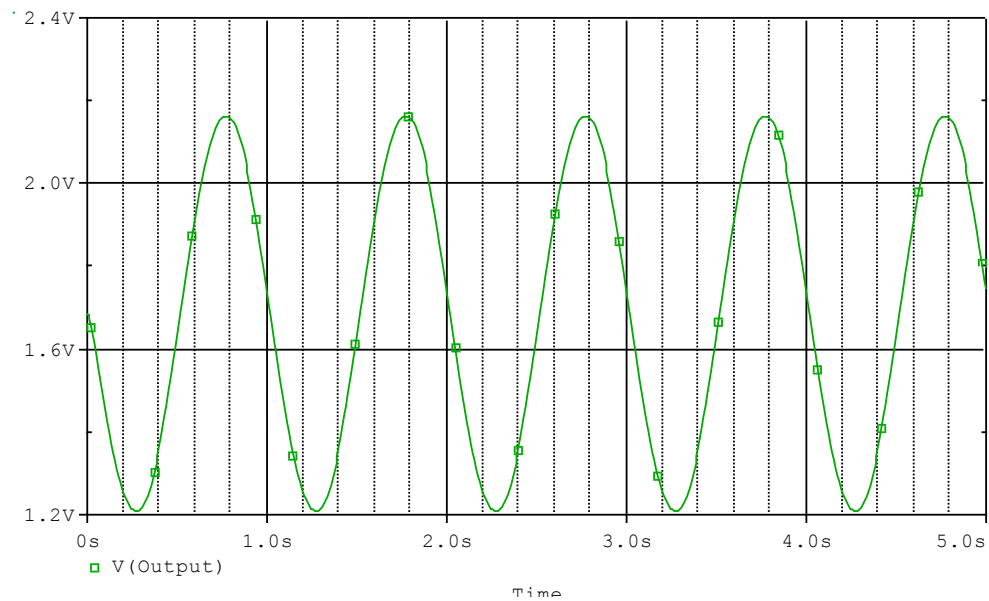


Comparison table

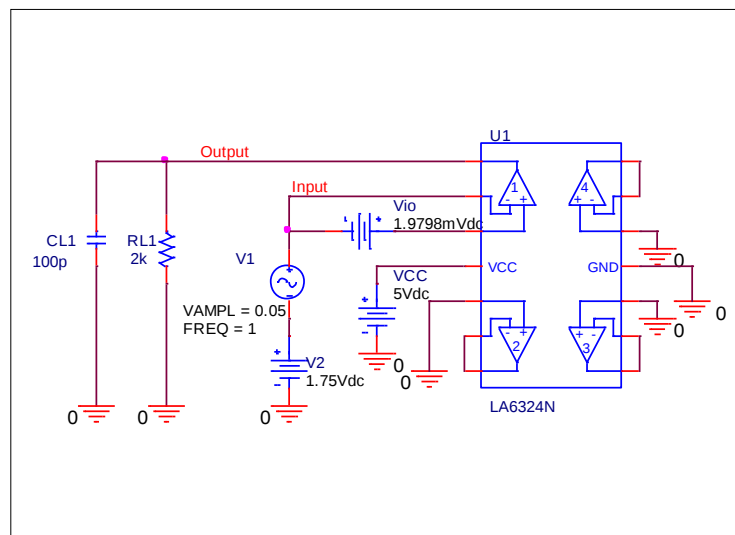
Parameter	Measurement	Simulation	%Error
Ft (MHz)	0.700	0.698	-0.23
AV (db)	100.000	99.975	-0.03

Common-mode rejection voltage gain

Simulation result



Evaluation circuit



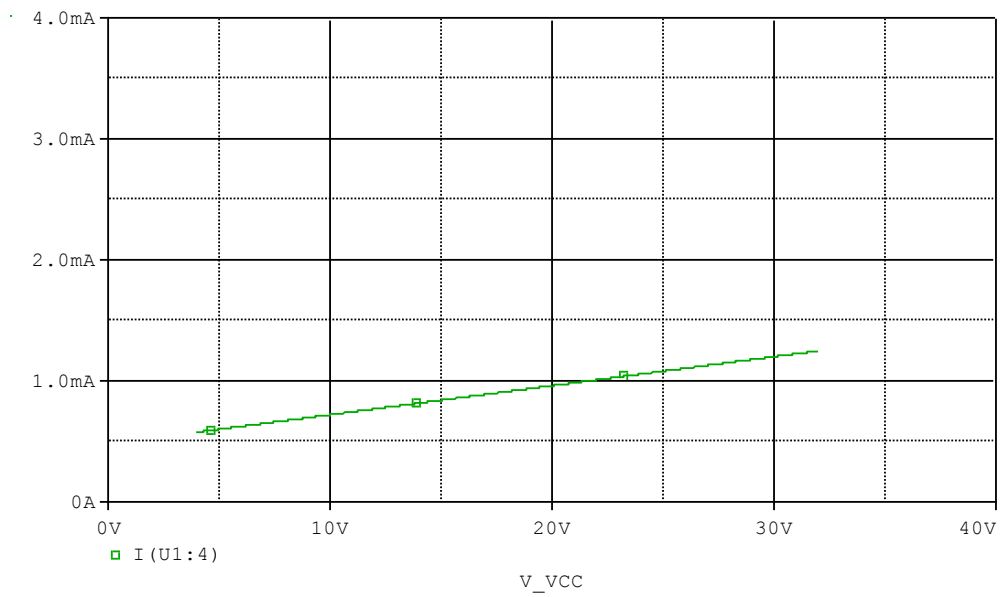
Comparison table

Common mode gain = 0.00954 V/mV
 $CMRR = 20\log(100/0.00954) = 80.406$

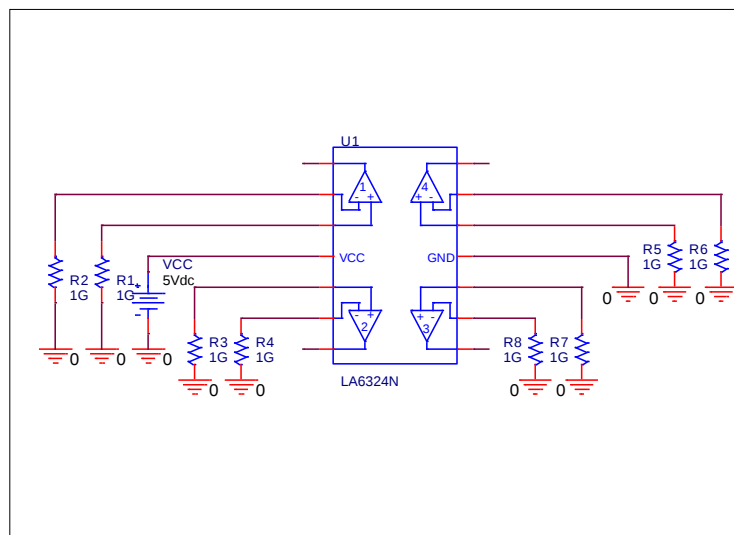
Parameter	Measurement	Simulation	%Error
CMRR(dB)	80.000	80.406	0.51

Supply Current

Simulation result



Evaluation circuit

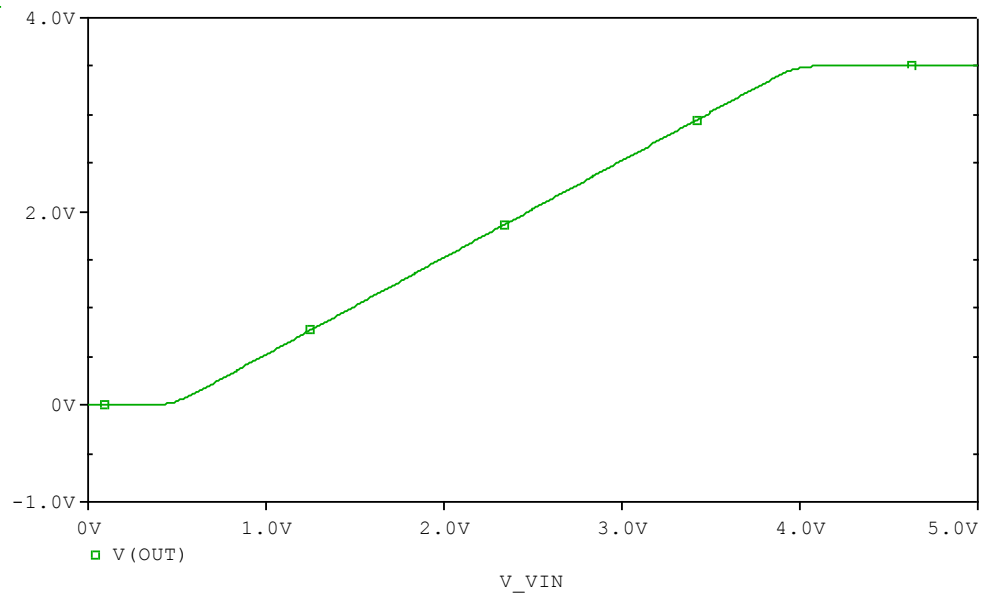


Comparison table

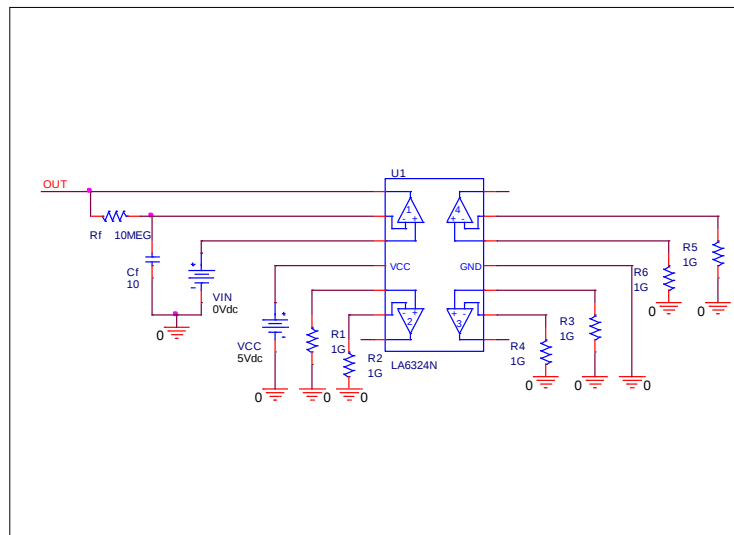
Parameter	Measurement	Simulation	%Error
ICC (mA)	1.200	1.200	0.00

Input common-mode voltage range

Simulation result



Evaluation circuit



Comparison table

Parameter	Measurement	Simulation	%Error
V_{icm} (V)	3.500	3.635	3.85